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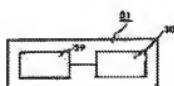
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(54) DATA PROCESSING APPARATUS

(57) Abstract:

PURPOSE: To make measuring values of a plurality of apparatus agree thereby to provide highly reliable measuring data, by connecting a plurality of automatic analyzing devices, calculating a correcting coefficient for each device from the measuring values of calibration samples obtained from the analyzing devices, and calibrating the difference of measuring values of the devices automatically.



CONSTITUTION: Several samples are measured for each analysis item in each automatic analyzing device. The data are sent to a data processing device 31 through an interface. The data are comparatively processed

to the data of a reference device at an operating part 29 of the processing device 31. The result is stored as a correcting coefficient in a memory part 30 of the processing device 31. The correcting coefficient is multiplied by a measuring value obtained from a general sample, and output from an output device connected to the processing device 31.

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